

Dual P-Channel 2.5-V (G-S) MOSFET

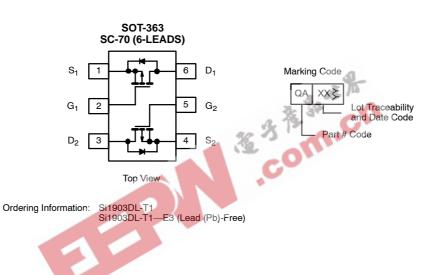
PRODUCT SUMMARY				
V _{DS} (V)	r _{DS(on)} (Ω)	I _D (A)		
-20	$0.995 @ V_{GS} = -4.5 V$	±0.44		
	1.190 @ V _{GS} = -3.6 V	±0.40		
	1.80 @ V _{GS} = -2.5 V	±0.32		

FEATURES

- TrenchFET® Power MOSFET
- 2.5-V Rated
- Lead (Pb)-Free Version is RoHS Compliant



Available



ABSOLUTE MAXIMUM RATINGS (T _A = 25°C UNLESS OTHERWISE NOTED)							
Parameter		Symbol	5 secs	Steady State	Unit		
Drain-Source Voltage		V _{DS}	-20		V		
Gate-Source Voltage		V _{GS}	±12				
Continuous Drain Current (T, I = 150°C) ^a	$T_A = 25^{\circ}C$	I _D	±0.44	±0.41			
	$T_A = 85^{\circ}C$		±0.31	±0.30	А		
Pulsed Drain Current		I _{DM}	± 1.0		~		
Continuous Diode Current (Diode Conduction) ^a		IS	-0.25	-0.23			
	$T_A = 25^{\circ}C$	- P _D	0.30	0.27	w		
Maximum Power Dissipation ^a	$T_A = 85^{\circ}C$		0.16	0.14	vv		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	–55 to 150		°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
	$t \le 5 \text{sec}$	R _{thJA}	360	415		
Maximum Junction-to-Ambient ^a	Steady State		400	460	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	300	350		

Notes

a. Surface Mounted on 1" x 1" FR4 Board.

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Parameter Syn		Test Condition	Min	Тур	Мах	Unit
Static						
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$	-0.6		-1.5	V
Gate-Body Leakage	I _{GSS}	$_{\rm S}$ V _{DS} = 0 V, V _{GS} = ±12 V			±100	nA
		$V_{DS} = -20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-1	μΑ
Zero Gate Voltage Drain Current	IDSS	V_{DS} = -20 V, V_{GS} = 0 V, T_{J} = 85 °C			-5	
On-State Drain Current ^a	I _{D(on)}	V_{DS} = -5 V, V_{GS} = -4.5 V	-1.0			Α
		$V_{GS} = -4.5 \text{ V}, \ I_D = -0.41 \text{ A}$		0.850	0.995	
Drain-Source On-State Resistance ^a	r _{DS(on)}	$V_{GS} = -3.6$ V, $I_D = -0.38$ A		1.0	1.190	Ω
		$V_{GS} = -2.5 \text{ V}, \text{ I}_{D} = -0.25 \text{ A}$		1.4	1.80	
Forward Transconductance ^a	9 _{fs}	$V_{DS} = -10$ V, $I_D = -0.41$ A		0.8		S
Diode Forward Voltage ^a	V _{SD}	I _S = -0.23 A, V _{GS} = 0 V		-0.8	-1.2	V
Dynamic ^b		1.5 1				
Total Gate Charge	Qg	$V_{DS} = -10$ V, $V_{GS} = -4.5$ V, $I_D = -0.41$ A	0	1.2	1.8	
Gate-Source Charge	Q _{gs}	V_{DS} = -10 V, V_{GS} = -4.5 V, I_D = -0.41 A		0.45		nC
Gate-Drain Charge	Q _{gd}			0.25		
Turn-On Delay Time	t _{d(on)}			7.5	15	
Rise Time	t _r	$V_{DD} = -10 \text{ V}, \text{ R}_{L} = 20 \Omega$		20	40	1
Turn-Off Delay Time	t _{d(off)}	$I_{D} \cong -0.5 \text{ A}, V_{GEN} = -4.5 \text{ V}, \text{ R}_{g} = 6 \Omega$		8.5	17	ns
Fall Time	t _f			12	24	1
Source-Drain Reverse Recovery Time	t _{rr}	I _F = -0.23 A, di/dt = 100 A/μs		25	40	1

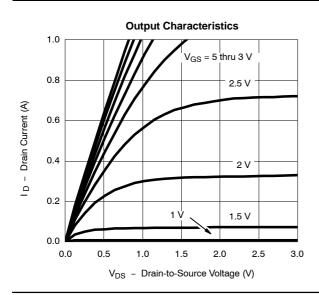
Notes

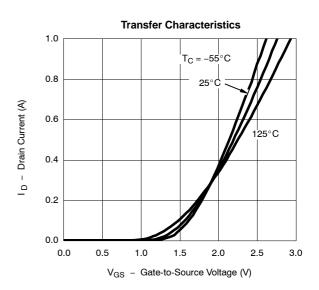
a.

Pulse test; pulse width \leq 300 µs, duty cycle \leq 2%. Guaranteed by design, not subject to production testing. b.

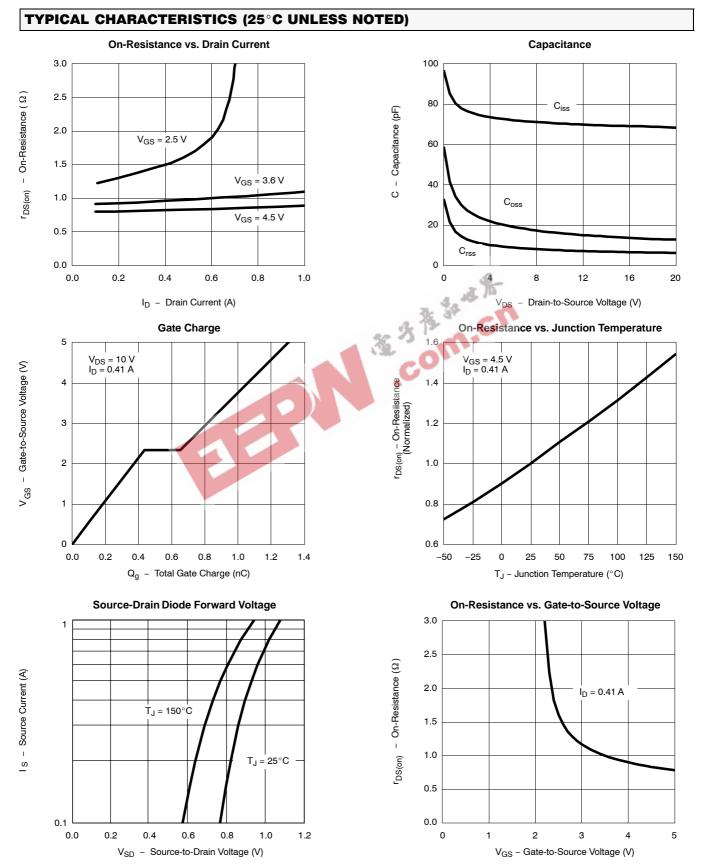
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)







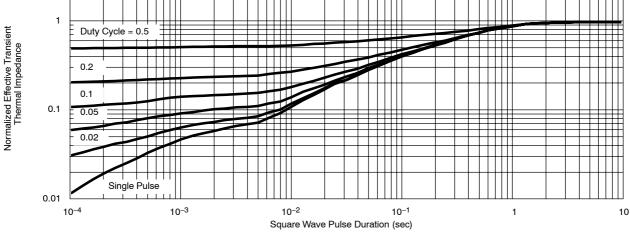


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TYPICAL CHARACTERISTICS (25°C UNLESS NOTED) Single Pulse Power Threshold Voltage 0.4 5 0.3 4 $I_D = 250 \ \mu A$ V_{GS(th)} Variance (V) 0.2 З Ś Power 0.1 2 0.0 1 -0.1 -0.2 0 10-2 -50 -25 0 25 50 75 100 125 150 10⁻³ 10-1 1 10 100 600 T_J – Temperature (°C) Time (sec) R Normalized Thermal Transient Impedance, Junction-to-Ambient 2 1 Normalized Effective Transient Thermal Impedance Duty Cycle = 0.5 1 1 1 1 1 0.2 Notes 0.1 4 P_{DM} 0.1 TH 0.05 t₁ 0.02 t₂ t₁ 1. Duty Cycle, D = 1. Duty Cycle, $D = \frac{t_2}{t_2}$ 2. Per Unit Base = R_{thJA} = 400°C/W 3. $T_{JM} - T_A = P_{DM}Z_{thJA}^{(t)}$ Sinale Pulse 4. Surface Mounted I I I I I I I 0.01 10^{_3} 10⁻² 10-1 10-4 1 10 100 600 Square Wave Pulse Duration (sec) Normalized Thermal Transient Impedance, Junction-to-Foot 2 1 Duty Cycle = 0.5 0.2 0.1 0.1 0.05



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